Application/Control No.	Applicant(s)/Patent under Reexamination
10/798,343	SAITO ET AL.
Examiner	Art Unit
Dinh Q. Nguyen	3752

SEARCHED							
Class	Subclass	Date	Examiner				
 							
239	585.1						
	533.2						
	900	12/5/05	(VX)				
239	6 00	12/5/05	WN				
251	129.15	9/25/06	CN				
UPDATED	SBARCH	9/25/06	20/2				

INTERFERENCE SEARCHED							
Class		Subclass	Date		Examiner		
23	9	282.1					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)							
	DATE	EXMR					
INTERFORENCE AND EACT SCARHES ATTACHED							
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